

1369788

Attorney's Docket No.: 14225-095US1 / F1040665WO00

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hideo Imaizumi et al. Art Unit : Unknown  
Serial No. : Examiner : Unknown  
Filed : February 24, 2006  
Title : CIRCUIT DEVICE AND METHOD OF MANUFACTURING THE SAME

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

# INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed and attached on the attached PTO-1449 form. An International Search Report (ISR) is also enclosed.

English-language abstracts are enclosed for Desig. ID Nos. AJ-AM and AO. Desig. ID No. AN (WO 03/063231) corresponds to Desig. ID No. AL (JP 2003-218147).

The relevance of Desig. ID Nos. AJ-AN is indicated in the ISR.

If requested by the Examiner, the undersigned will arrange to have English-language translations of the listed references prepared and provided to the Patent Office.

This statement is being filed with the application. Please apply any charges or credits to  
Deposit Account No. 06-1050.

Respectfully submitted,

Date: 2/24/06

 James Bondar

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Sheet 1 of 1

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14225-095US1	Application No. 60/788
<b>Information Disclosure Statement</b> <b>by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Hideo Imaizumi et al.	
		Filing Date February 24, 2006	Group Art Unit

<b>U.S. Patent Documents</b>							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

<b>Foreign Patent Documents or Published Foreign Patent Applications</b>							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Abst
							Yes
	AJ	07-326928	12/12/1995	Japan			X
	AK	09-162345	06/20/1997	Japan			X
	AL	2003-218147	07/31/2003	Japan			X
	AM	02-166903	06/27/1990	Japan			X
	AN	WO 03/063231	07/31/2003	WIPO			X
	AO	2000-124847	04/28/2000	Japan			X

<b>Other Documents (include Author, Title, Date, and Place of Publication)</b>		
Examiner Initial	Desig. ID	Document
	AP	
	AQ	
	AR	
	AS	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	